

Notice of References Cited	Application/Control No. 10/675,690	Applicant(s)/Patent Under Reexamination MAEHARA ET AL.	
	Examiner Maria N. Von Buhr	Art Unit 2125	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0117374 A1	06-2004	Hung et al.	707/010
	B	US-2004/0107214 A1	06-2004	Hung et al.	707/104.1
	C	US-2004/0098391 A1	05-2004	Robertson et al.	707/010
	D	US-2004/0054982 A1	03-2004	Schepp et al.	716/021
	E	US-2003/0126153 A1	07-2003	Clairmont et al.	707/104.1
	F	US-2002/0188910 A1	12-2002	Zizzo, Claudio	716/1
	G	US-2002/0081501 A1	06-2002	Hasegawa et al.	430/5
	H	US-2002/0016948 A1	02-2002	Rein et al.	716/1
	I	US-2001/0044667 A1	11-2001	Nakano et al.	700/100
	J	US-6,725,237 B2	04-2004	Clairmont et al.	707/104.1
	K	US-6,668,360 B1	12-2003	Liu, Louis	716/4
	L	US-6,622,295 B1	09-2003	Schepp et al.	716/19
	M	US-6,594,799 B1	07-2003	Robertson et al.	716/1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.